- **Phase-Locked Loop-Based Multiplier by Four**

- **Input Frequency Range: 2.5 MHz to 45 MHz**

- **Output Frequency Range: 10 MHz to 180 MHz**

- **LVCMOS/LVTTL I/O Compatible**

- **Low Jitter (Cycle-Cycle): ±120 ps Over the Range 75 MHz to 180 MHz**

- **Distributes One Clock Input to Two Banks of Four Outputs**

- **Auto Frequency Detection to Disable Device (Power-Down Mode)**

- **Operates From Single 3.3-V Supply**

- **Industrial Temperature Range –40°C to 85°C**

- **25-Ω On-Chip Series Damping Resistors**

- **No External RC Network Required**

- **Spread Spectrum Clock Compatible (SSC)**

- **Available in 16-Pin TSSOP Package**

PW PACKAGE (TSSOP)
(TOP VIEW)

CLKIN	1	16 FBIN
1Y0	2	15 1Y3
1Y1	3	14 1Y2
V_{DD}	4	13 V_{DD}
GND	5	12 GND
2Y0	6	11 2Y3
2Y1	7	10 2Y2
S2	8	9 S1
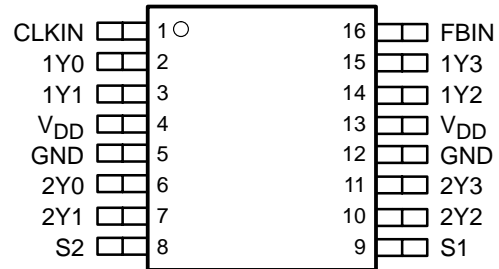
description

The CDCVF25084 is a high-performance, low-skew, low-jitter, phase-lock loop clock multiplier. It uses a PLL to precisely align, in both frequency and phase, the output clocks to the input clock signal including a multiplication factor of four. The CDCVF25084 operates from a nominal supply voltage of 3.3 V. The device also includes integrated series-damping resistors in the output drivers that make it ideal for driving point-to-point loads.

Two banks of four outputs each provide low-skew, low-jitter copies of CLKIN x four. All outputs operate at the same frequency. Output duty cycles are adjusted to 50%, independent of duty cycle at CLKIN. The device automatically goes into power-down mode when no input signal is applied to CLKIN and the outputs go into a low state. Unlike many products containing PLLs, the CDCVF25084 does not require an external RC network. The loop filter for the PLL is included on-chip, minimizing component count, space, and cost.

Because it is based on a PLL circuitry, the CDCVF25084 requires a stabilization time to achieve phase lock of the feedback signal to the reference signal. This stabilization is required following power up and application of a fixed-frequency signal at CLKIN and any following changes to the PLL reference.

The CDCVF25084 is characterized for operation from –40°C to 85°C.

FUNCTION TABLE

S2	S1	1Y0–1Y3	2Y0–2Y3	OUTPUT SOURCE	PLL SHUTDOWN
0	0	Hi-Z	Hi-Z	N/A	Yes
0	1	Active	Hi-Z	PLL[†]	No
1	0	Active	Active	Input clock (PLL bypass)	Yes
1	1	Active	Active	PLL[†]	No

[†] A CLK input frequency < 2 MHz switches the outputs to low level.

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Terminal Functions

TERMINAL		TYPE	DESCRIPTION
NAME	PIN NO.		
1Y[0:3]	2, 3, 14, 15	O	Bank 1Yn clock outputs. These outputs are low-skew copies of CLKIN. Each output has an integrated 25-Ω series-damping resistor.
2Y[0:3]	6, 7, 10, 11	O	Bank 2Yn clock outputs. These outputs are low-skew copies of CLKIN. Each output has an integrated 25-Ω series-damping resistor.
CLKIN	1	I	Clock input. CLKIN provides the clock signal to be distributed by the CDCVF25084 clock driver. CLKIN is used to provide the reference signal to the integrated PLL that generates the output signal. CLKIN must have a fixed frequency and phase in order for the PLL to acquire lock. Once the circuit is powered up and a valid signal is applied, a stabilization time is required for the PLL to phase lock the feedback signal to CLKIN.
FBIN	16	I	Feedback input. FBIN provides the feedback signal to the internal PLL. FBIN must be wired to one of the outputs to complete the feedback loop of the internal PLL. The integrated PLL synchronizes the FBIN and output signal so there is nominally zero-delay from input clock to output clock.
GND	5, 12	Ground	Ground
S1, S2	9, 8	I	Select pins to determine mode of operation. See the *FUNCTION TABLE* for mode selection options.
V_{DD}	4, 13	Power	Supply voltage. The supply voltage range is 3 V to 3.6 V

functional block diagram
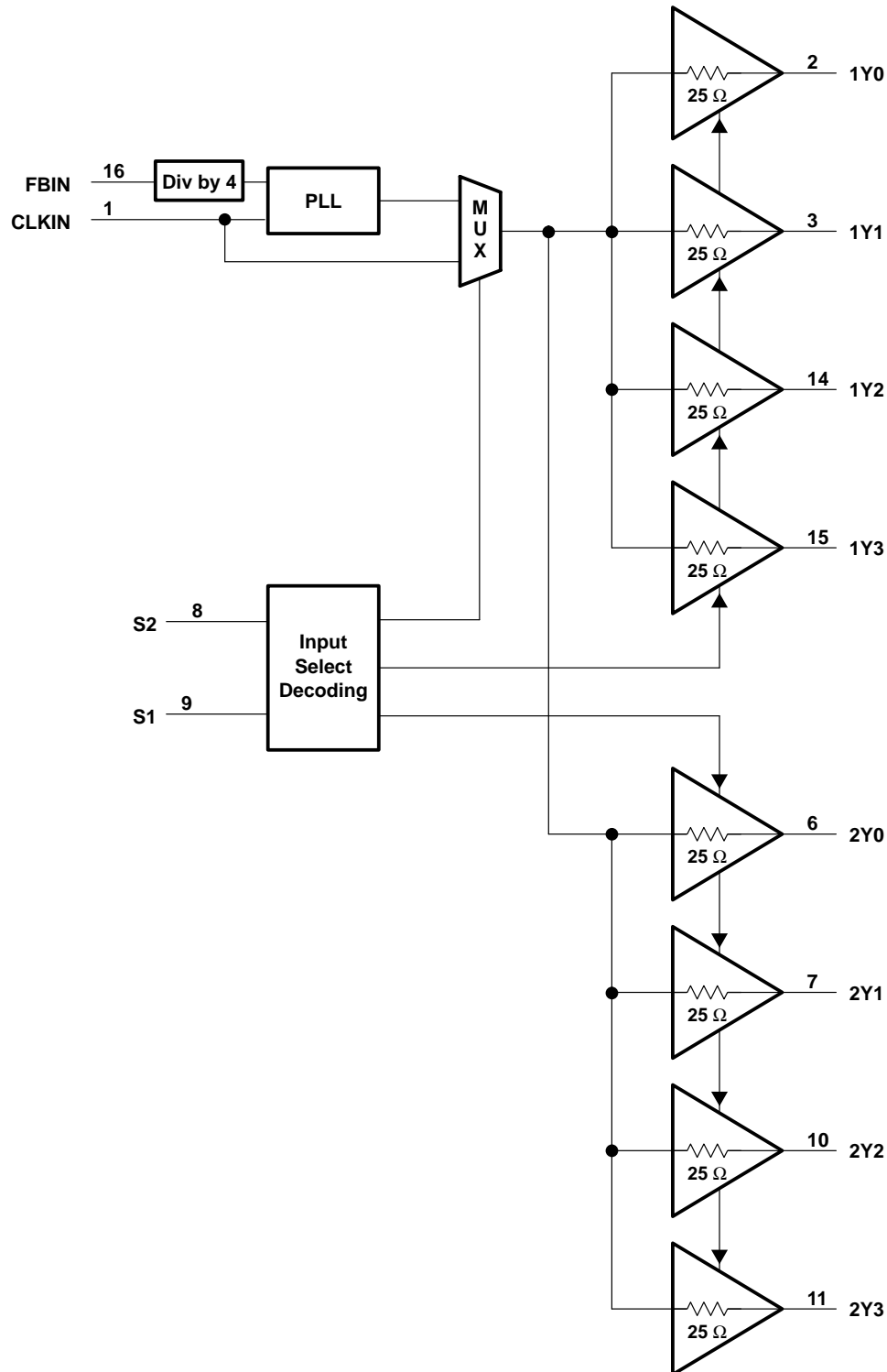
absolute maximum ratings over operating free-air temperature (unless otherwise noted)†

Supply voltage range, V_{DD} .... –0.5 V to 4.6 V
Input voltage range, V_I (see Notes 1 and 2) .... –0.5 V to 4.6 V
Output voltage range, V_O (see Notes 1 and 2) .... –0.5 V to V_{DD} + 0.5 V
Input clamp current, I_{IK} ($V_I < 0$) .... –50 mA
Output clamp current, I_{OK} ($V_O < 0$) .... –50 mA
Continuous total output current, I_O ($V_O = 0$ to V_{DD}) .... ±50 mA
Package thermal impedance, θ_{JA} (see Note 3):   PW package .... 147°C/W
Storage temperature range, T_{stg} .... –65°C to 150°C

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
2. This value is limited to 4.6 V maximum.
3. The package thermal impedance is calculated in accordance with JESD 51.

recommended operating conditions

	MIN	NOM	MAX	UNIT
Supply voltage, V_{DD}	3	3.3	3.6	V
Low level input voltage, V_{IL}			0.8	V
High level input voltage, V_{IH}	2			V
Input voltage, V_I	0		3.6	V
High-level output current, I_{OH}			–12	mA
Low-level output current, I_{OL}			12	mA
Operating free-air temperature, T_A	–40		85	°C

timing requirements over recommended ranges of supply voltage, load and operating free-air temperature

		MIN	NOM	MAX	UNIT
Input clock frequency, f_{CLKIN}		2.5		45	MHz
Input clock duty cycle		40%		60%	
Clock frequency, f_{clkout}	$C_L = 15$ pF	10		180	MHz

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP[†]	MAX	UNIT
V_{IK}	Input voltage	V_{DD} = 3 V,	I_I = −18 mA			−1.2	V
I_I	Input current	V_I = 0 V or V_{DD}				±5	µA
I_{PD}	Power-down current	f_{CLKIN} = 0 MHz,	V_{DD} = 3.3 V			100	µA
I_{DD}[‡]	Dynamic current	f_{out} = 80 MHz,	C_L = 15 pF		60	80	mA
I_{OZ}	Output 3-state	V_O = 0 V or V_{DD},	V_{DD} = 3.6 V			±5	µA
C_I	Input capacitance at FBIN, CLKIN	V_I = 0 V or V_{DD}			4		pF
C_I	Input capacitance at S1, S2	V_I = 0 V or V_{DD}			2.2		pF
C_O	Output capacitance	V_I = 0 V or V_{DD}			3		pF
V_{OH}	High-level output voltage	V_{DD} = min to max,	I_{OH} = −100 µA	V_{DD} − 0.2			V
		V_{DD} = 3 V,	I_{OH} = −12 mA	2.1			
		V_{DD} = 3 V,	I_{OH} = −6 mA	2.4			
V_{OL}	Low-level output voltage	V_{DD} = min to max,	I_{OL} = 100 µA			0.2	V
		V_{DD} = 3 V,	I_{OL} = 12 mA			0.8	
		V_{DD} = 3 V,	I_{OL} = 6 mA			0.55	
I_{OH}	High-level output current	V_{DD} = 3 V,	V_O = 1 V	−24			mA
		V_{DD} = 3.3 V,	V_O = 1.65 V		−30		
		V_{DD} = 3.6 V,	V_O = 3.135 V			-15	
I_{OL}	Low-level output current	V_{DD} = 3 V,	V_O = 1.95 V	26			mA
		V_{DD} = 3.3 V,	V_O = 1.65 V		33		
		V_{DD} = 3.6 V,	V_O = 0.4 V			14	

† All typical values are at respective nominal V_{DD}.
‡ All outputs are switching; for I_{DD} over frequency see Figure 9.

switching characteristics over recommended operating free-air temperature range (unless otherwise noted)

| PARAMETER		TEST CONDITIONS	MIN	TYP†	MAX	UNIT
$t_{(lock)}$	PLL lock time	f_{out} = 100 MHz		2		µs
$t_{(phoffset)}$	Phase offset (CLKIN to FBIN), (see Note 5)	f_{out} = 40 MHz to 75 MHz, Vth = V_{DD}/2			±200	ps
		f_{out} = 75 MHz to 180 MHz, Vth = V_{DD}/2			±100	
t_{PLH}, t_{PHL}	Propagation delay	S2 = High, S1 = Low (PLL bypass mode)	2.3		4.5	ns
$t_{sk(o)}$	Output skew (Yn to Yn) (see Note 4)	See Figure 3		75	150	ps
$t_{sk(pp)}$	Part-to-part skew (low-to-high transition)	PLL bypass mode			900	ps
		PLL mode, f_{out} = 40 MHz to 75 MHz			350	
		PLL mode, f_{out} = 75 MHz to 180 MHz			300	
$t_{jit(cc)}$	Jitter (cycle-to-cycle)	f_{out} = 40 MHz to 75 MHz			±220	ps
		f_{out} = 75 MHz to 180 MHz			±120	ps
$t_{jit(per)}$	Period jitter	f_{out} = 40 MHz to 75 MHz			260	ps
		f_{out} = 75 MHz to 180 MHz			140	ps
$t_{jit(\theta)}$	Phase jitter	f_{out} = 75 MHz to 180 MHz, peak-to-peak (see Note 6)			±110	ps
		f_{out} = 75 MHz to 180 MHz, RMS (see Note 6)			26	ps
odc	Output duty cycle	f_{out} = 10 MHz to 180 MHz	45%		55%	
$t_{sk(p)}$	Pulse skew	S2 = High, S1 = low (PLL bypass mode)			0.3	ns
t_r, t_f	Rise / fall time rate	See Figure 4	1		3	V/ns

† All typical values are at respective nominal V_{DD}.

NOTES: 4. The $t_{sk(o)}$ specification is only valid for equal loading of all outputs.
5. Similar waveform at CLKIN and FBIN are required. Output 1Y3 is used as a feedback to FBIN loaded with 11 pF and all other outputs have 15 pF. For phase displacement between CLKIN and Y-outputs, see Figure 5.
6. Input phase jitter < ±50 ps; output sample size is 20000 cycles.

PARAMETER MEASUREMENT INFORMATION
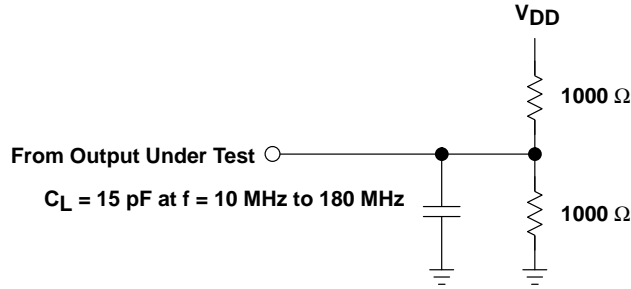
NOTES: A. C_L includes probe and jig capacitance.
B. All input pulses are supplied by generators having the following characteristics: $Z_O = 50\ \Omega$, $t_r < 1.2$ ns, $t_f < 1.2$ ns
C. The outputs are measured one at a time with one transition per measurement.
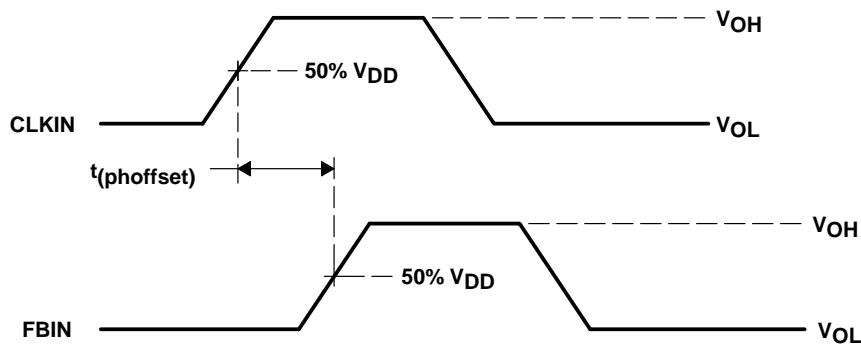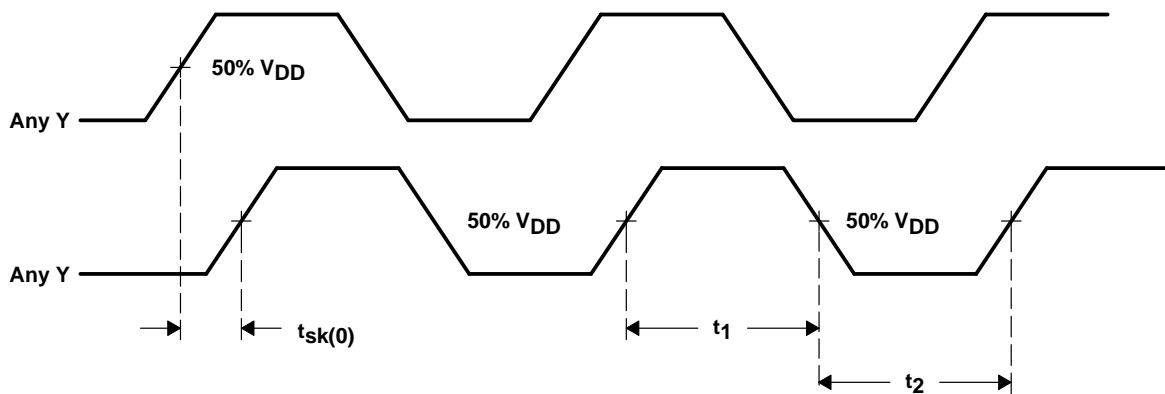
Figure 1. Test Load Circuit

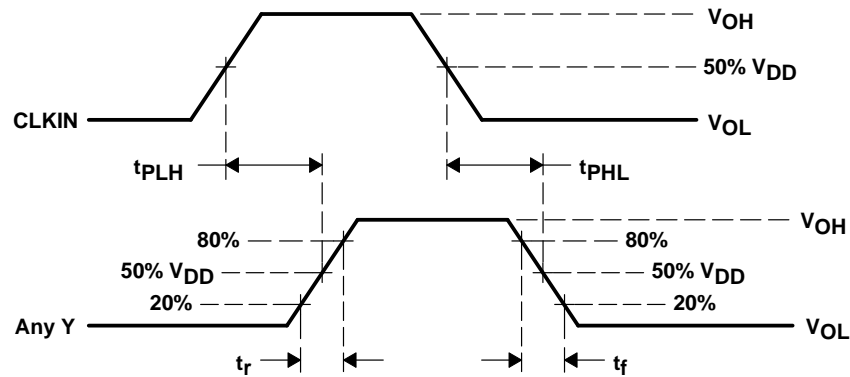**Figure 2. Voltage Thresholds for Measurements, Phase Offset (PLL Mode)**

NOTE: odc = $t_1/(t_1 + t_2)$ x 100%

Figure 3. Output Skew and Output Duty Cycle (PLL Mode)

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PARAMETER MEASUREMENT INFORMATION

NOTE: $t_{sk(p)} = |t_{PLH} - t_{PHL}|$

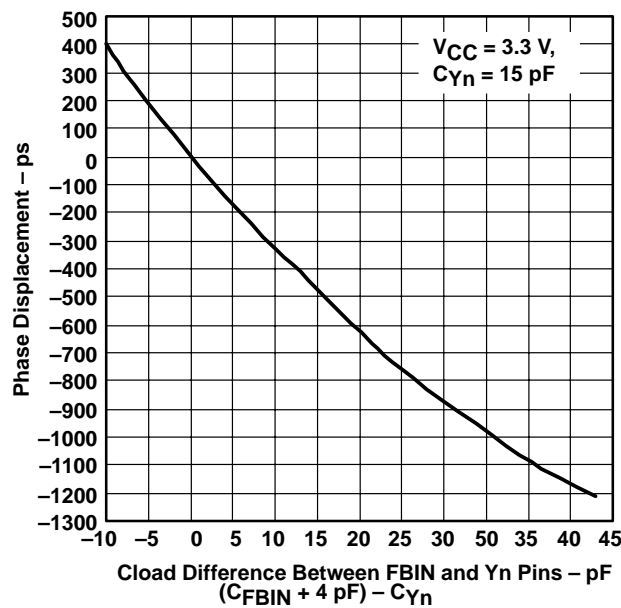**Figure 4. Propagation Delay and Pulse Skew (Non-PLL Mode)**

PHASE DISPLACEMENT
vs
CLOAD

$V_{CC} = 3.3$ V,
$C_{Yn} = 15$ pF

Cload Difference Between FBIN and Yn Pins – pF
$(C_{FBIN} + 4$ pF$) - C_{Yn}$

Figure 5

PHASE OFFSET
vs
FREQUENCY

$C_{L(Yn)} = 15$ pF,
$C_{L(FBIN)} = 11$ pF

f – Output Frequency – MHz

Figure 6

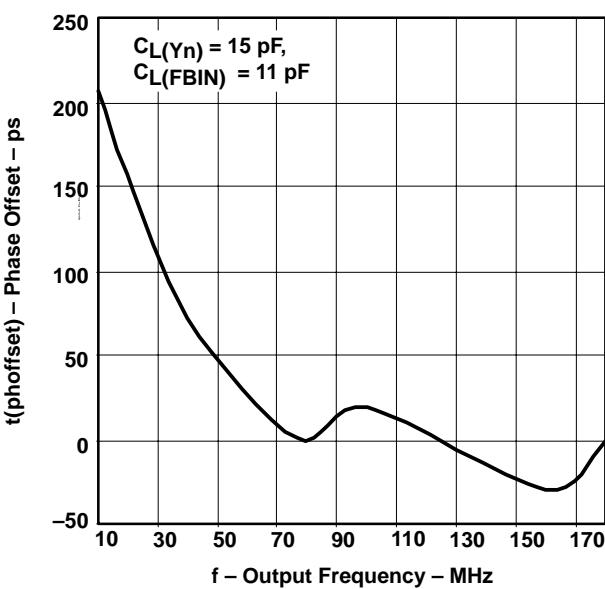TEXAS
INSTRUMENTS

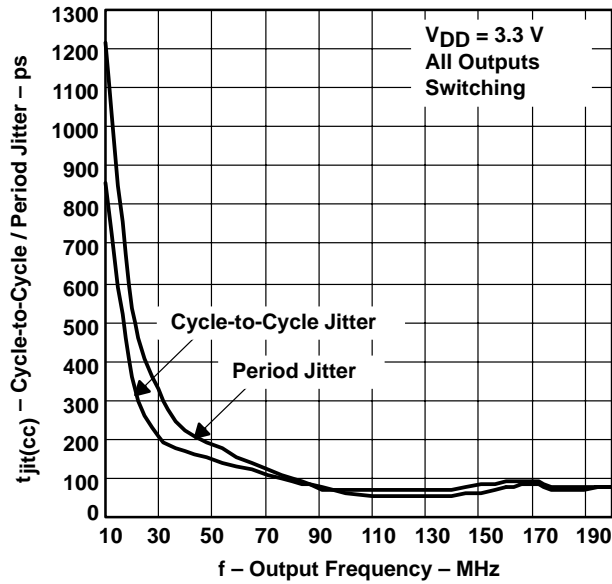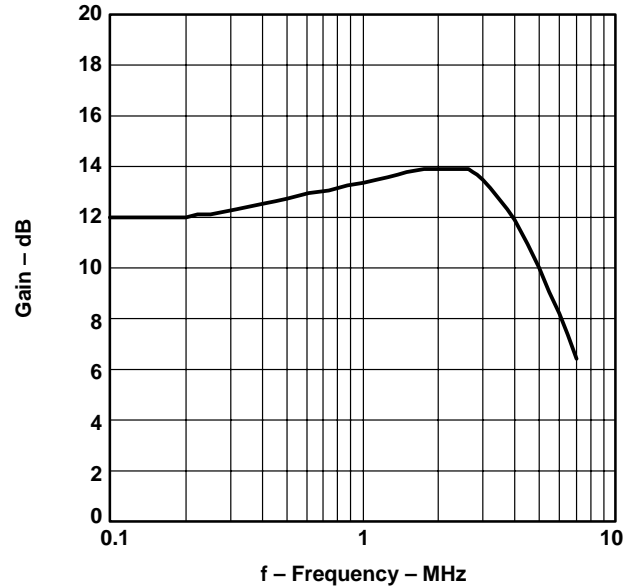POST OFFICE BOX 655303 ● DALLAS, TEXAS 75265

PARAMETER MEASUREMENT INFORMATION

**CYCLE-TO-CYCLE / PERIOD JITTER
vs
FREQUENCY**

Figure 7

TRANSFER CHARACTERISTIC FROM CLKIN TO Yn

Figure 8

**SUPPLY CURRENT
vs
FREQUENCY**
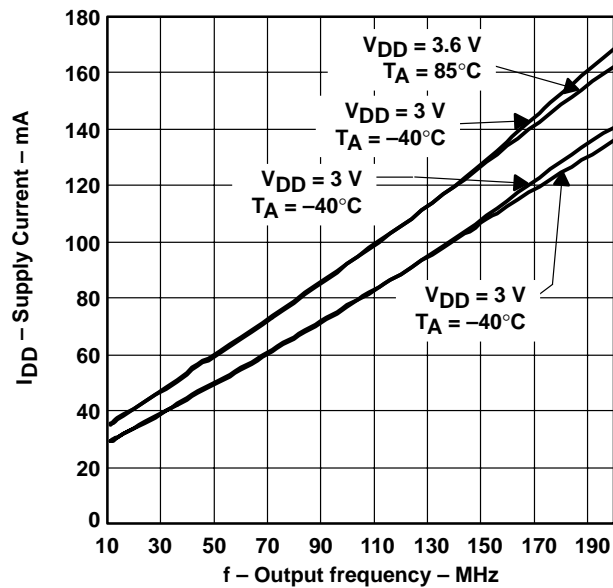
Figure 9

MECHANICAL DATA

PW (R-PDSO-G**)   **PLASTIC SMALL-OUTLINE PACKAGE**

14 PINS SHOWN
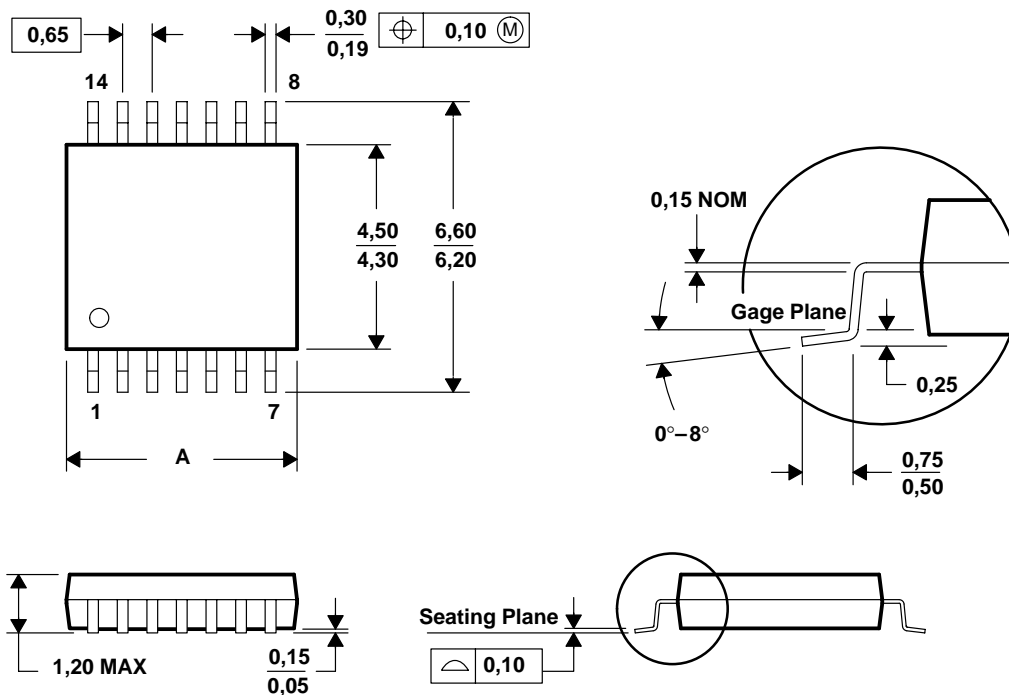
DIM \ PINS **	8	14	16	20	24	28
A MAX	3,10	5,10	5,10	6,60	7,90	9,80
A MIN	2,90	4,90	4,90	6,40	7,70	9,60

4040064/F 01/97

NOTES: A. All linear dimensions are in millimeters.
         B. This drawing is subject to change without notice.
         C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.
         D. Falls within JEDEC MO-153

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PW (R-PDSO-G**)   **PLASTIC SMALL-OUTLINE PACKAGE**

14 PINS SHOWN

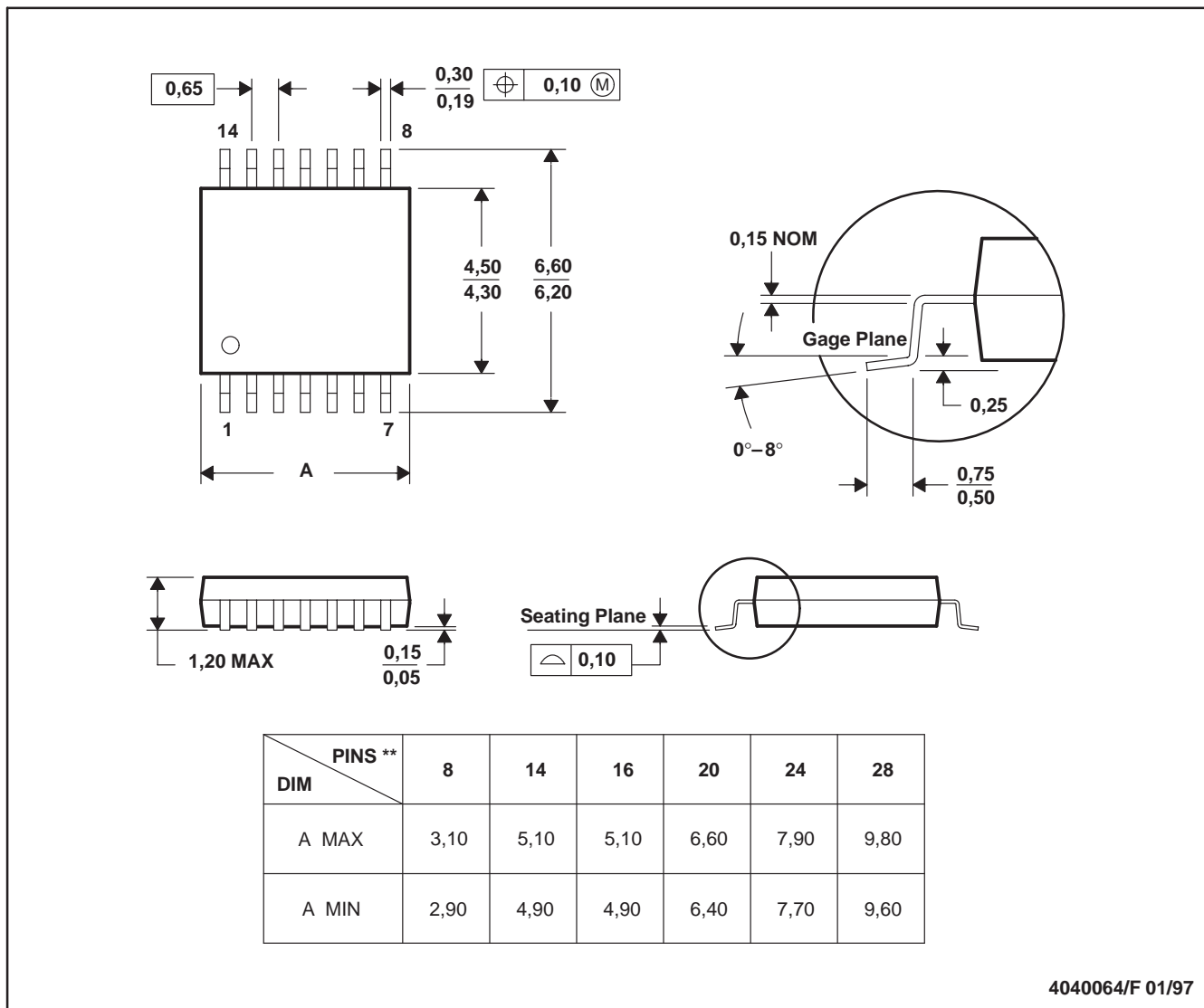| PINS ** DIM	8	14	16	20	24	28
A MAX	3,10	5,10	5,10	6,60	7,90	9,80
A MIN	2,90	4,90	4,90	6,40	7,70	9,60

4040064/F 01/97

NOTES: A. All linear dimensions are in millimeters.
        B. This drawing is subject to change without notice.
        C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.
        D. Falls within JEDEC MO-153

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Mailing Address:

Texas Instruments
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Dallas, Texas 75265

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